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ON Semiconductor®

# FDPF18N20FT-G N-Channel UniFET<sup>™</sup> FRFET® MOSFET 200 V, 18 A, 140 m

#### **Features**

- $R_{DS(on)}$  = 129 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 9 A
- Low Gate Charge (Typ. 20 nC)
- Low C<sub>rss</sub> (Typ. 24 pF)
- 100% Avalanche Tested
- · Improve dv/dt Capability
- · RoHS Compliant

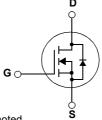
### **Applications**

- LCD/LED TV
- Consumer Appliances
- Lighting
- Uninterruptible Power Supply
- · AC-DC Power Supply

# **Description**

UniFET™ MOSFET is ON Semiconductor®'s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. The body diode's reverse recovery performance of UniFET FRFET® has been enhanced by lifetime control. Its t⁺ is less than 100nsec and the reverse dv/dt immunity is 15V/ns while normal planar MOSFETs have over 200nsec and 4.5V/nsec respectively. Therefore, it can remove additional component and improve system reliability in certain applications in which the performance of MOSFET's body diode is significant. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





## MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol		Parameter		FDPF18N20FT-G	Unit
$V_{DSS}$	Drain to Source Voltage			200	V
$V_{GSS}$	Gate to Source Voltage			±30	V
_	Drain Current	-Continuous (T <sub>C</sub> = 25°C)		18*	А
ID	Diamourient	-Continuous (T <sub>C</sub> = 100°C)		10.8*	A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	72*	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energ	у	(Note 2)	324	mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	18	Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	10	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns
D	Dower Dissinction	$(T_C = 25^{\circ}C)$		35	W
$P_{D}$	Power Dissipation	- Derate above 25°C		0.27	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Tempera	ature Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature fo 1/8" from Case for 5 Seconds	r Soldering Purpose,		300	°C

<sup>\*</sup>Drain current limited by maximum junction temperature

#### **Thermal Characteristics**

Symbol	Parameter	FDPF18N20FT-G	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	3.6	
$R_{\theta CS}$	Thermal Resistance, Case to Sink, Typ.	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	•

# Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

<b>Device Marking</b>	Device	Package	Eco Status	Reel Size	Tape Width	Quantity
FDPF18N20FT	FDPF18N20F-G	TO-220F	Green/RoHS	-	-	50

## **Electrical Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$ , $V_{GS} = 0 V$ , $T_J = 25 ^{\circ} C$	200	-	-	V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.2	-	V/°C
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V	-	-	10	^
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 160V, T_C = 125^{\circ}C$	-	-	100	μА
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 9A	-	0.12	0.14	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20V, I_{D} = 9A$ (Note 4)	-	13.6	-	S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V		-	885	1180	pF
Coss	Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1MHz		-	200	270	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 110112		-	24	35	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V			-	20	26	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 160V, I_{D} = 18A$		-	5	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V	(Note 4, 5)	-	9	-	nC

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	16	40	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 100V, I_D = 18A$	-	50	110	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 25\Omega$	-	50	110	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)	-	40	90	ns

#### **Drain-Source Diode Characteristics**

IS	Maximum Continuous Drain to Source Diode Forward Current			-	-	18	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	72	Α	
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 18A		-	-	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 18A		-	80	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_{F}/dt = 100A/\mu s $ (N	Note 4)	-	240	-	nC

#### Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 2mH, I<sub>AS</sub> = 18A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 $\Omega$ , Starting T<sub>J</sub> = 25 $^{\circ}$ C
- 3. I  $_{SD} \leq$  18A, di/dt  $\leq$  200A/ $\mu$ s, V  $_{DD} \leq$  BV  $_{DSS}$ , Starting T  $_{J}$  = 25°C
- 4. Pulse Test: Pulse width  $\leq 300 \mu s,$  Duty Cycle  $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

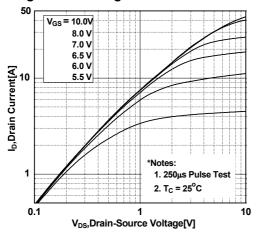


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

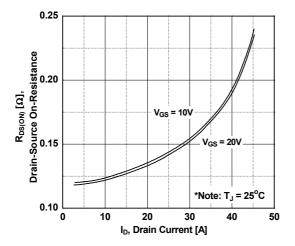


Figure 5. Capacitance Characteristics

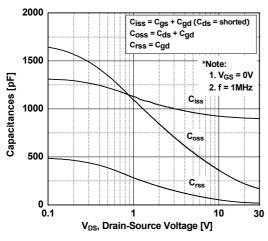


Figure 2. Transfer Characteristics

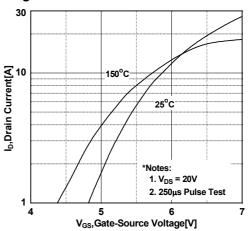


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

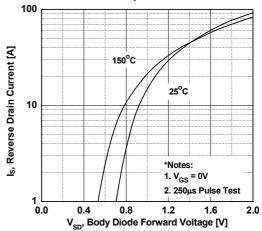
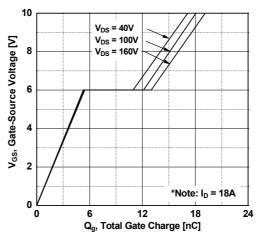


Figure 6. Gate Charge Characteristics



## **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

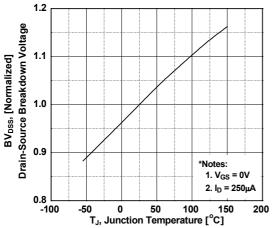


Figure 9. Maximum Drain Current

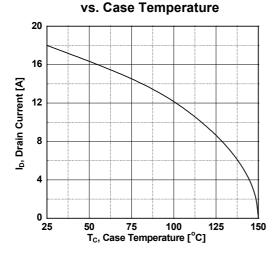


Figure 8. Maximum Safe Operating Area - FDP18N20F

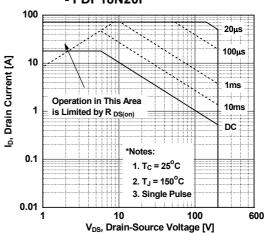
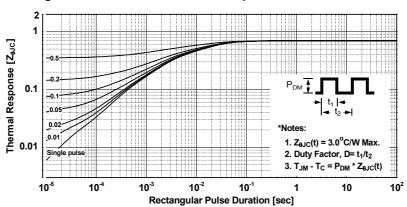
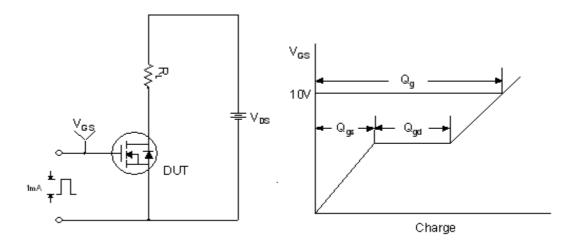


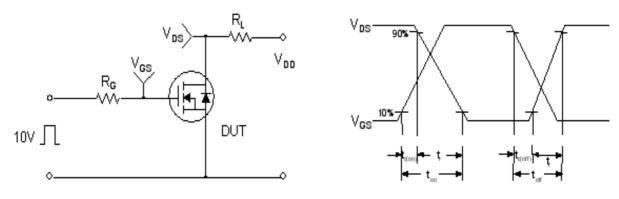
Figure 10. Transient Thermal Response Curve - FDP18N20F



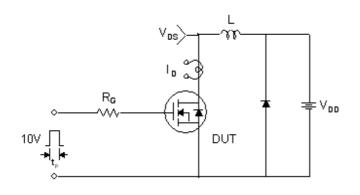
## **Gate Charge Test Circuit & Waveform**

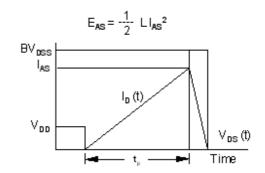


### **Resistive Switching Test Circuit & Waveforms**

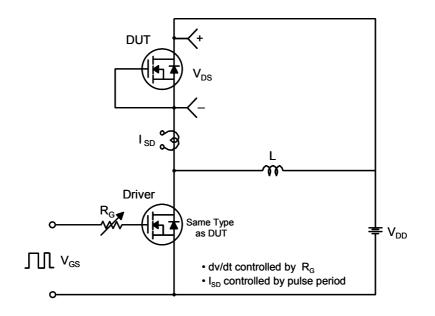


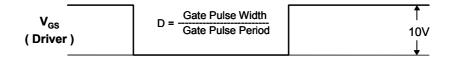
**Unclamped Inductive Switching Test Circuit & Waveforms** 

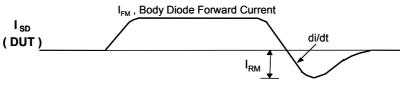




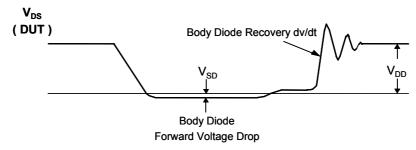
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







**Body Diode Reverse Current** 



## **Mechanical Dimensions** TO-220M03 2.742.34 10.36 Α 9.96 Ø 3.28 7.00 3.40 3.08 ( 0.70 ) 3.20 SEE NOTE "F" SEE NOTE "F" 6.88 6.48 $\oplus$ 1 X 45° 16.07 15.67 16.00 15.60 (3.23) B 3 1.47 2.96 1.24 2.14 2.56 0.90 10.05 0.70 9.45 $\oplus$ 0.50 M A 30° 0.45 0.60 0.25 0.45 2.54 2.54 NOTES: A. EXCEPT WHERE NOTED CONFORMS TO EIAJ SC91A. D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND THE BAR AS DEPARTMENT. 4.90 <u> ∕B</u>\ 4.50 E. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994 F. OPTION 1 - WITH SUPPORT PIN HOLE. OPTION 2 - NO SUPPORT PIN HOLE. G. DRAWING FILE NAME: TO220M03REV3 **Dimensions in Millimeters**

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